Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/624,234	RITLAND, STEPHEN	
Examiner	Art Unit	
John Kim	3733	

	SEAR	CHED		
Class	Subclass	Date	Examiner	
606	61	6/15/2006	JK	1
				

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Seach notes	6/15/2006	JK
Inventor's name search	6/15/2006	JK